

1M BIT (65,536 WORD × 16 BIT) CMOS MASK ROM

DESCRIPTION

The TC531024P/F is a 1,048,576 bits read only memory organized as 65,536 words by 16 bits.

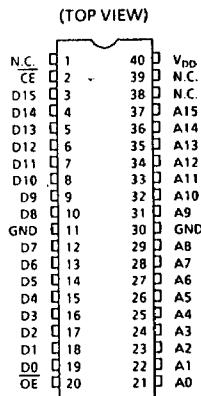
The TC531024P/F is fabricated using Toshiba's advanced CMOS technology which provides the high speed and low power features with access time of 120ns / 150ns, an operation current of 40mA at 8.3MHz and a standby current of 20 μ A.

The TC531024P/F is packaged in a standard 600mil 40pin DIP, or 525mil 40pin SOP.

FEATURES

TC531024P/F	-12	-15
Power Supply	5V ± 5%	5V ± 10%
Access Time (Max.)	120ns	150ns
Power Dissipation : Operating Current (Max.)	40mA	35mA
Power Dissipation : Standby Current (Max.)	20 μ A	20 μ A

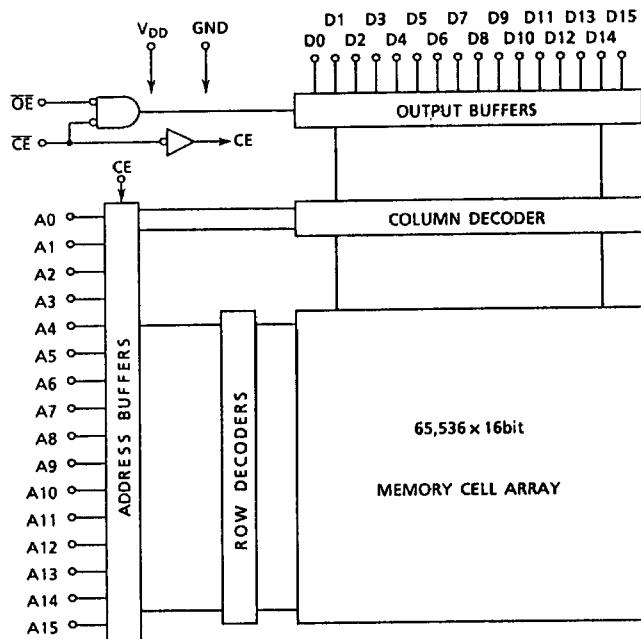
PIN CONNECTION



PIN NAMES

A0~A15	Address inputs
D0~D15	Data Outputs
OE	Output Enable Input
CE	Chip Enable Input
V _{DD}	Power Supply
GND	Ground
N.C.	No Connection

BLOCK DIAGRAM



TC531024P-12, TC531024P-15

TC531024F-12, TC531024F-15

MAXIMUM RATINGS

SYMBOL	ITEM	RATING	UNIT
V_{DD}	Power Supply Voltage	-0.5~7.0	V
V_{IN}	Input Voltage	-0.5~ V_{DD}	V
V_{OUT}	Output Voltage	0~ V_{DD}	V
P_D	Power Dissipation	1.0 / 0.6*	W
T_{STG}	Storage Temperature	-55~150	°C
T_{OPR}	Operating Temperature	0~70	°C
T_{SOLDER}	Soldering Temperature - Time	260 · 10	°C · sec

Note : * Plastic FP.

D.C. OPERATING CONDITIONS ($T_a = 0 \sim 70^\circ\text{C}$)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V_{DD}	Power Supply Voltage	4.5	5.5	V
V_{IH}	Input High Voltage	2.2	$V_{DD} + 0.3$	V
V_{IL}	Input Low Voltage	-0.3	0.8	V

D.C. OPERATING CHARACTERISTICS ($T_a = 0 \sim 70^\circ\text{C}$, $V_{DD} = 5\text{V} \pm 10\%$)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I_{IL}	Input Leakage Current	$0V \leq V_{IN} \leq V_{DD}$	-	± 1.0	μA
I_{LO}	Output Leakage Current	$0V \leq V_{OUT} \leq V_{DD}$	-	± 5.0	μA
I_{OH}	Output High Current	$V_{OH} = 2.4\text{V}$	-1.0	-	mA
I_{OL}	Output Low Current	$V_{OL} = 0.4\text{V}$	3.2	-	
I_{DDS1}	Standby Current	$\bar{CE} = 2.2\text{V}$	-	2.0	μA
I_{DDS2}		$\bar{CE} = V_{DD} - 0.2\text{V}$	-	20	
I_{DDO1}	Operating Current	$\bar{CE} = V_{IL}, V_{IN} = V_{IH}/V_{IL}$ $I_{OUT} = 0\text{mA}$	$t_{cycle} = 120\text{ns}$	50	mA
I_{DDO2}		$\bar{CE} = 0.2\text{V}, V_{IN} = V_{DD} - 0.2\text{V} / 0.2\text{V}$ $I_{OUT} = 0\text{mA}$	$t_{cycle} = 150\text{ns}$	45	
			$t_{cycle} = 120\text{ns}$	40	
			$t_{cycle} = 150\text{ns}$	35	

CAPACITANCE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
C_{IN}	Input Capacitance	$f = 1\text{MHz}, T_a = 25^\circ\text{C}$	-	10	pF
C_{OUT}	Output Capacitance	$f = 1\text{MHz}, T_a = 25^\circ\text{C}$	-	10	pF

Note : This Parameter is periodically sampled and is not 100% tested.

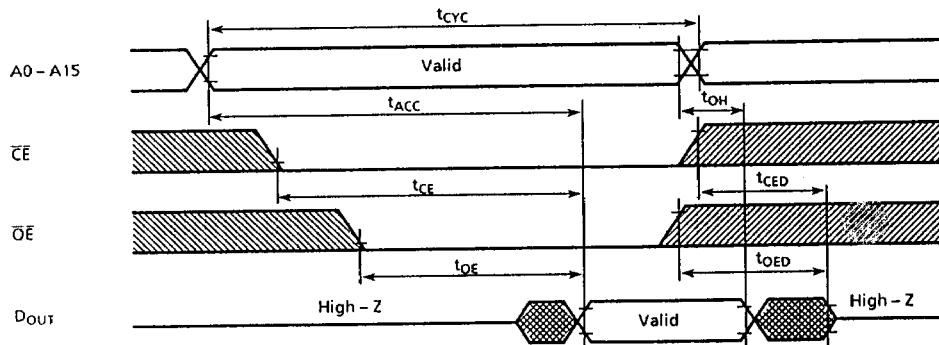
A.C. CHARACTERISTICS ($T_a = 0^\circ\text{C} \sim 70^\circ\text{C}$)

SYMBOL	PARAMETER	$V_{DD} = 5V \pm 5\%$		$V_{DD} = 5V \pm 10\%$		UNIT
		MIN.	MAX.	MIN.	MAX.	
t_{ACC}	Access Time	-	120	-	150	ns
t_{CE}	Chip Enable Access Time	-	120	-	150	ns
t_{OE}	Output Enable Access Time	-	70	-	70	ns
t_{CED}	Output Disable Time from \bar{CE}	0	60	0	60	ns
t_{OED}	Output Disable Time from \bar{OE}	0	60	0	60	ns
t_{OH}	Output Hold Time	5	-	5	-	ns
t_{CYC}	Cycle Time	120	-	150	-	ns

A.C. TEST CONDITIONS

Output Load : 100pF + 1TTL
 Input Levels : 0.6V / 2.4V
 Timing Measurement Reference Levels Input : 0.8V / 2.2V
 Output : 0.8V / 2.0V
 Input Rise and Fall Time (10%~90%) : 5ns

TIMING WAVEFORMS



OPERATION MODE

MODE	\bar{CE}	\bar{OE}	A0~A15	Outputs	Power
Read	L	L	Valid	Data Out	Operating
Standby	H	*	*	High-Z	Standby
Output Deselect	L	H	*	High-Z	Operating

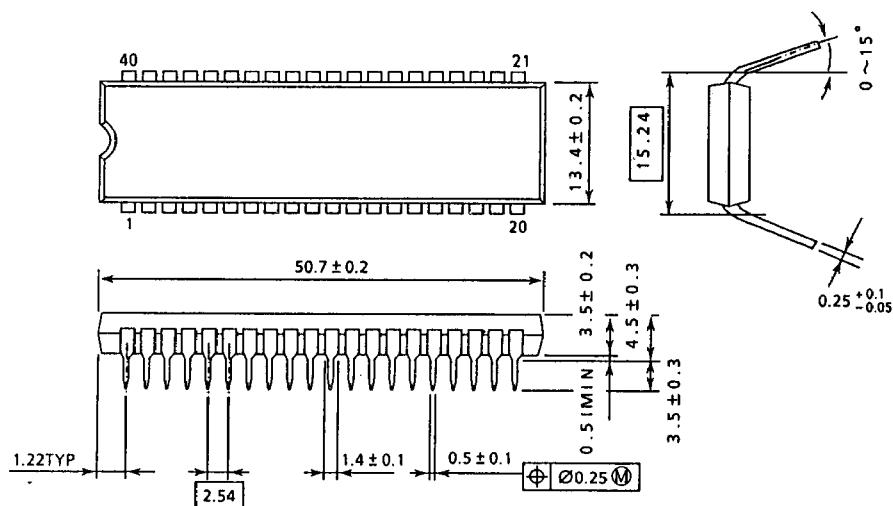
H : VIH L : VIL * : VIH or VIL

**TC531024P-12, TC531024P-15
TC531024F-12, TC531024F-15**

OUTLINE DRAWINGS

Plastic DIP (DIP40-P-600)

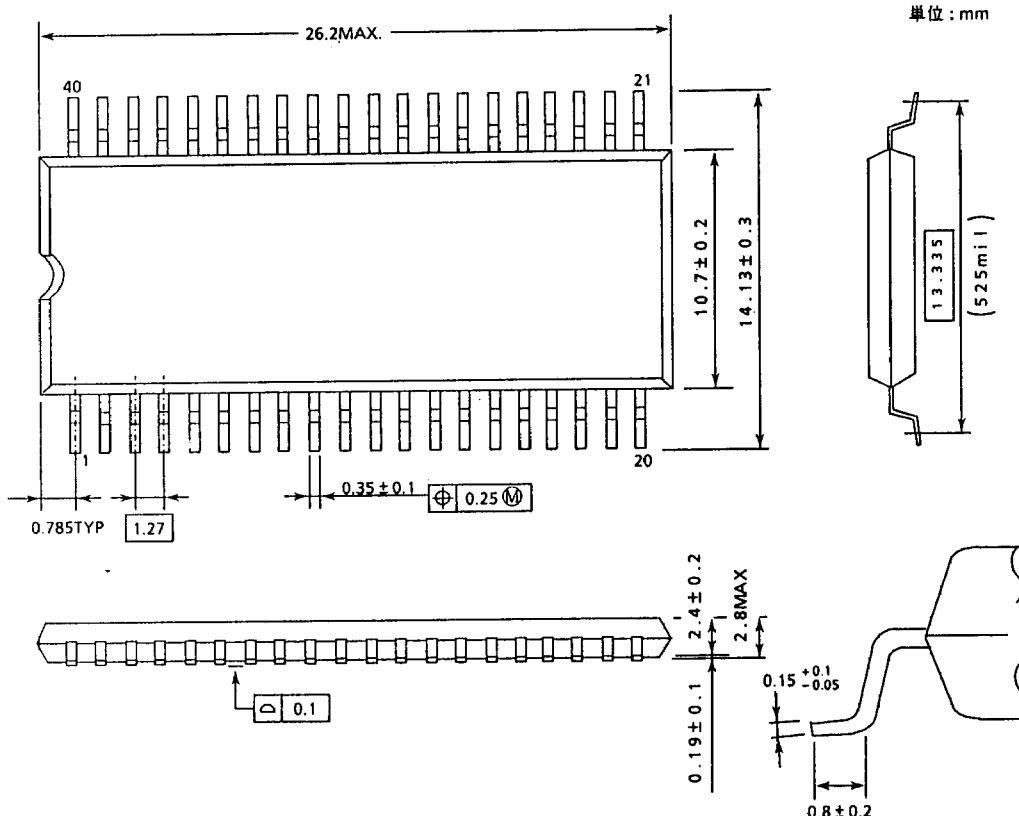
单位 : mm



Note: Package width and length do not include mold protrusion, allowable mold protrusion is 0.15mm.

OUTLINE DRAWINGS

Plastic FP (SOP40-P-525)



Note : Package width and length do not include mold protrusion ,allowable mold protrusion is 0.15mm.